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Substitute for form 1449A/B/PTO				Complete If Known		
				Application Number	Not Yet Assigned 10/583,811	
INFORMATION DISCLOSURE				Filing Date	October 10, 2006	
l s	TATEMENT 6	3Y /	APPLICANT	First Named Inventor	Kazuma Yokoi	
				Art Unit	2884	
(Use as many sheets as necessary)			necessary)	Examiner Name	M. H. Taningco	
Sheet	1	of	1	Attorney Docket Number	A8319.0023/P023-A	

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NON PATENT LITERATURE DOCUMENTS					
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MT	CA*	European Search Report, dated 4/28//06			
MT	CB.	JP Office Action, dated 4/25/06			
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